

ADC0844/ADC0848 8-Bit µP Compatible A/D Converters with Multiplexer Options

Check for Samples: ADC0844, ADC0848

FEATURES

- Easy Interface to All Microprocessors
- Operates Ratiometrically or with 5 V_{DC} Voltage Reference
- No Zero or Full-Scale Adjust Required
- 4-Channel or 8-Channel Multiplexer with Address Logic
- Internal Clock
- 0V to 5V Input Range with Single 5V Power Supply
- Standard Width 20-Pin or 24-Pin PDIP
- 28 Pin PLCC Package

KEY SPECIFICATIONS

· Resolution: 8 Bits

Total Unadjusted Error: ±½ LSB and ± 1 LSB

Single Supply: 5 V_{DC}
 Low Power: 15 mW
 Conversion Time: 40 µs

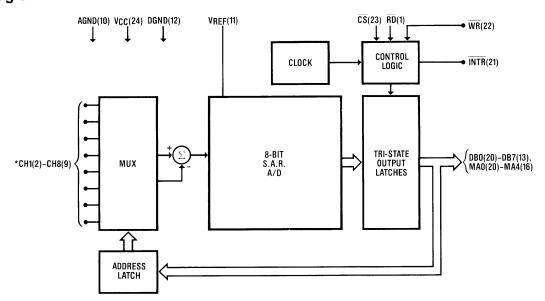
DESCRIPTION

The ADC0844 and ADC0848 are CMOS 8-bit successive approximation A/D converters with versatile analog input multiplexers. The 4-channel or 8-channel multiplexers can be software configured for single-ended, differential or pseudo-differential modes of operation.

The differential mode provides low frequency input common mode rejection and allows offsetting the analog range of the converter. In addition, the A/D's reference can be adjusted enabling the conversion of reduced analog ranges with 8-bit resolution.

The A/Ds are designed to operate from the control bus of a wide variety of microprocessors. TRI-STATE output latches that directly drive the data bus permit the A/Ds to be configured as memory locations or I/O devices to the microprocessor with no interface logic necessary.

Block Diagram



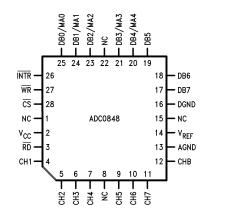
^{*} ADC0848 shown in PDIP Package CH5-CH8 not included on the ADC0844

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Connection Diagram



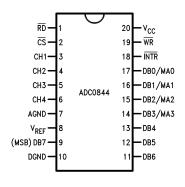


Figure 1. PLCC Package (Top View)

Figure 2. 20-Pin PDIP (Top View)

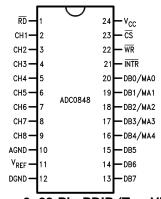


Figure 3. 28-Pin PDIP (Top View)



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings (1)(2)(3)

Supply Voltage (V _{CC})			6.5V				
Voltage	Logic Control Inputs		-0.3V to +15V				
Voltage	At Other Inputs and Outp	-0.3V to V _{CC} +0.3V					
Input Current at Any Pin (4)							
Package Input Current ⁽⁴⁾		20 mA					
Storage Temperature		−65°C to +150°C					
Package Dissipation at T _A =25°C		875 mW					
ESD Susceptibility ⁽⁵⁾			800V				
	PDIP Package		260°C				
Lead Temperature (Soldering, 10 seconds)	DI CC Dookogo	Vapor Phase (60 seconds)	215°C				
	PLCC Package	Infrared (15 seconds)	220°C				

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. DC and AC electrical specifications do not apply when operating the device beyond its specified operating conditions.
- (2) All voltages are measured with respect to the ground pins.
- (3) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/Distributors for availability and specifications.
- (4) When the input voltage (V_{IN}) at any pin exceeds the power supply rails (V_{IN} < V⁻or V_{IN} > V⁺) the absolute value of the current at that pin should be limited to 5 mA or less. The 20 mA package input current limits the number of pins that can exceed the power supply boundaries with a 5 mA current limit to four.
- (5) Human body model, 100 pF discharged through a 1.5 kΩ resistor.

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Operating Conditions (1)(2)

Supply Voltage (V _{CC})		4.5 V _{DC} to 6.0 V _{DC}
	ADC0844CCN, ADC0848BCN, ADC0848CCN	0°C≤T _A ≤70°C
Temperature Range $(T_{MIN} \le T_A \le T_{MAX})$	ADC0844BCJ ⁽³⁾ , ADC0844CCJ ⁽³⁾ , ADC0848BCV, ADC0848CCV	-40°C≤T _A ≤85°C

- Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. DC and AC electrical specifications do not apply when operating the device beyond its specified operating conditions.
- (2) All voltages are measured with respect to the ground pins.
- (3) Product/package combination obsolete; shown for reference only.

Electrical Characteristics

The following specifications apply for $V_{CC} = 5 V_{DC}$ unless otherwise specified. **Boldface limits apply from T_{MIN} to T_{MAX}**; all other limits $T_A = T_i = 25$ °C.

	Parameter	Conditions	AD AD	C0844BC	.၂ ⁽¹⁾ .၂ ⁽¹⁾	AI AI AI AI	Limit Units		
			Typ ⁽²⁾	Tested Design Limit ⁽³⁾		Typ ⁽²⁾	Tested Limit ⁽³⁾	Design Limit ⁽⁴⁾	
CONVERTE	R AND MULTIPLEXER CHA	RACTERISTICS							
Maximum To	otal								
	ADC0844BCN, ADC0848BCN, BCV	$V_{RFF} = 5.00 V_{DC}^{(5)}$					±½	±1/2	LSB
Unadjusted Error	ADC0844CCN, ADC0848CCN, CCV	V _{REF} = 5.00 V _{DC}					±1	±1	LSB
ADC0844CCJ ⁽¹⁾				±1					LSB
Minimum Re	ference Input Resistance		2.4	1.1		2.4	1.2	1.1	kΩ
Maximum Re	eference Input Resistance		2.4	5.9		2.4	5.4	5.9	kΩ
Maximum Co	ommon-Mode Input Voltage	See ⁽⁶⁾		V _{CC} + 0.05			V _{CC} + 0.05	V _{CC} + 0.05	V
Minimum Co	mmon-Mode Input Voltage	See ⁽⁶⁾		GND - 0.05			GND - 0.05	GND - 0.05	V
DC Commor	n-Mode Error	Differential Mode	±1/16	±1/4		±1/16	±1/4	±1/4	LSB
Power Supp	y Sensitivity	$V_{CC} = 5V\pm5\%$	±1/16	±1/8		±1/16	±1/8	±1/8	LSB
Off Channel	Laslana Current	On Channel = 5V, Off Channel = 0V ⁽⁷⁾		-1			-0.1	-1	μA
Off Channel Leakage Current		On Channel = 0V, Off Channel = 5V		1			0.1	1	μA
DIGITAL AN	D DC CHARACTERISTICS	•	*						
V _{IN(1)} , Logica	al "1" Input Voltage (Min)	V _{CC} = 5.25V		2.0			2.0	2.0	V
V _{IN(0)} , Logica	al "0" Input Voltage (Max)	V _{CC} = 4.75V		0.8			0.8	0.8	V
I _{IN(1)} , Logica	"1" Input Current (Max)	V _{IN} = 5.0V	0.005	1		0.005		1	μΑ
I _{IN(0)} , Logica	"0" Input Current (Max)	V _{IN} = 0V	-0.005	-1		-0.005		-1	μA

- (1) This product/package combination is obsolete. Shown for reference only.
- (2) Typical figures are at 25°C and represent most likely parametric norm.
- (3) Tested limits are specified to TI's AOQL (Average Outgoing Quality Level).
- (4) Design limits are specified by not 100% tested. These limits are not used to calculate outgoing quality levels.
- (5) Total unadjusted error includes offset, full-scale, linearity, and multiplexer error.
- (6) For V_{IN} (¬) ≥ V_{IN}(+) the digital output code will be 0000 0000. Two on-chip diodes are tied to each analog input, which will forward-conduct for analog input voltages one diode drop below ground or one diode drop greater than V_{CC} supply. Be careful during testing at low V_{CC} levels (4.5V), as high level analog inputs (5V) can cause this input diode to conduct, especially at elevated temperatures, and cause errors for analog inputs near full-scale. The spec allows 50 mV forward bias of either diode. This means that as long as the analog V_{IN} does not exceed the supply voltage by more than 50 mV, the output code will be correct. To achieve an absolute 0 V_{DC} to 5 V_{DC} input voltage range will therefore require a minimum supply voltage of 4.950 V_{DC} over temperature variations, initial tolerance and loading.
- (7) Off channel leakage current is measured after the channel selection.



Electrical Characteristics (continued)

The following specifications apply for V_{CC} = 5 V_{DC} unless otherwise specified. Boldface limits apply from T_{MIN} to T_{MAX} ; all other limits $T_A = T_j = 25$ °C.

Parameter	Conditions		C0844BC C0844CC		1A 1A 1A 1A	Limit Units		
		Typ ⁽²⁾	Tested Limit ⁽³⁾	Design Limit ⁽⁴⁾	Typ ⁽²⁾	Tested Limit ⁽³⁾	Design Limit ⁽⁴⁾	
\/ Logical "4" Output \/oltogo (Min)	$V_{CC} = 4.75V$, $I_{OUT} = -360 \mu A$		2.4			2.8	2.4	V
V _{OUT(1)} , Logical "1" Output Voltage (Min)	I _{OUT} = -10 μA		4.5			4.6	4.5	V
V _{OUT(0)} , Logical "0" Output Voltage (Max)	$V_{CC} = 4.75V$, $I_{OUT} = 1.6$ mA		0.4			0.34	0.4	V
I _{OUT} , TRI-STATE Output Current (Max)	V _{OUT} = 0V	-0.01	-3		-0.01	-0.3	-3	μΑ
1 _{OUT} , TRI-STATE Output Current (Max)	V _{OUT} = 5V	0.01	3		0.01	0.3	3	μA
I _{SOURCE} , Output Source Current (Min)	V _{OUT} = 0V	-14	-6.5		-14	-7.5	-6.5	mA
I _{SINK} , Output Sink Current (Min)	$V_{OUT} = V_{CC}$	16	8.0		16	9.0	8.0	mA
I _{CC} , Supply Current (Max)	CS = 1, V _{REF} Open	1	2.5		1	2.3	2.5	mA

AC Electrical Characteristics

The following specifications apply for $V_{CC} = 5V_{DC}$, $t_r = t_f = 10$ ns unless otherwise specified. Boldface limits apply from T_{MIN} to T_{MAX} ; all other limits $T_{\Delta} = T_{i} = 25^{\circ}$ C.

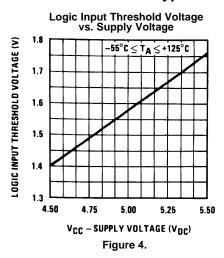
Parameter	Conditions	Typ ⁽¹⁾	Tested Limit ⁽²⁾	Design Limit ⁽³⁾	Units
t _C , Maximum Conversion Time (See Figure 7)		30	40	60	μs
t _{W(WR)} , Minimum WR Pulse Width	See ⁽⁴⁾	50	150		ns
t _{ACC} , Maximum Access Time (Delay from Falling Edge of \overline{RD} to Output Data Valid)	C _L = 100 pF ⁽⁴⁾	145		225	ns
$\underline{t_{1H.}}$ $t_{0H.}$ TRI-STATE Control (Maximum Delay from Rising Edge of RD to Hi-Z State)	$C_L = 10 \text{ pF}, R_L = 10 \text{k}^{(4)}$	125		200	ns
$t_{W_{\underline{I}}}$, $t_{R_{\underline{I}}}$, Maximum Delay from Falling Edge of \overline{WR} or \overline{RD} to Reset of INTR	(0)	200	400		ns
t _{DS} , Minimum Data Set-Up Time	See ⁽⁴⁾	50	100		ns
t _{DH} , Minimum Data Hold Time		0	50		ns
C _{IN} , Capacitance of Logic Inputs		5			pF
C _{OUT} , Capacitance of Logic Outputs		5			pF

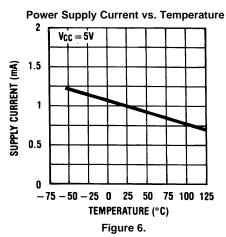
- Typical figures are at 25°C and represent most likely parametric norm.
- Tested limits are specified to Tl's AOQL (Average Outgoing Quality Level).

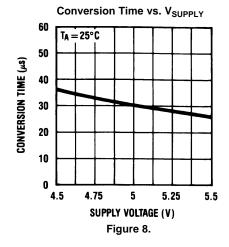
 Design limits are specified by not 100% tested. These limits are not used to calculate outgoing quality levels.
- The temperature coefficient is 0.3%/°C.



Typical Performance Characteristics







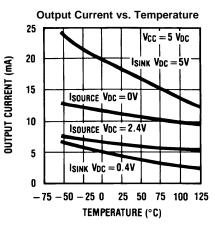
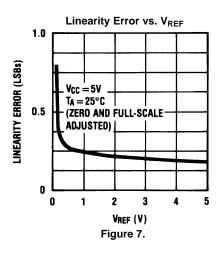
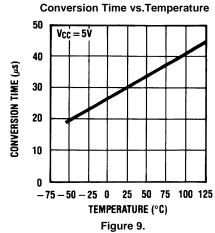
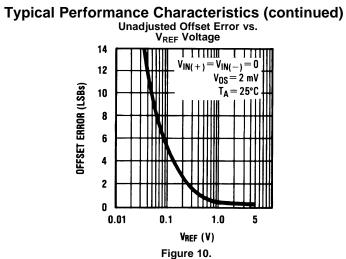


Figure 5.

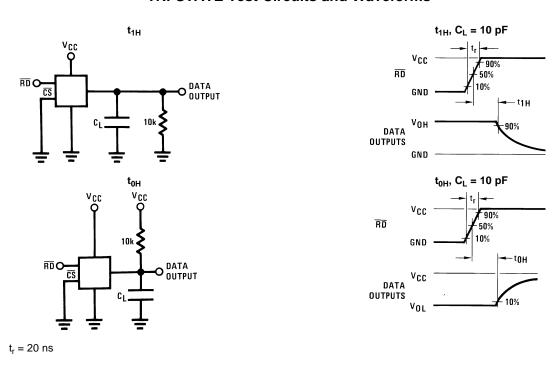




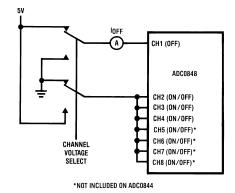




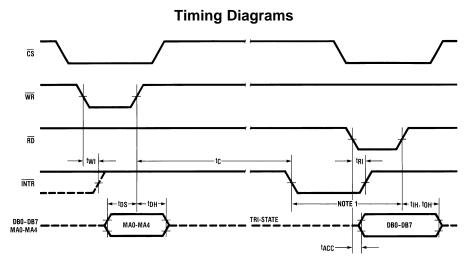
TRI-STATE Test Circuits and Waveforms



Leakage Current Test Circuit

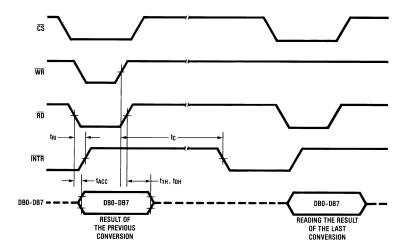






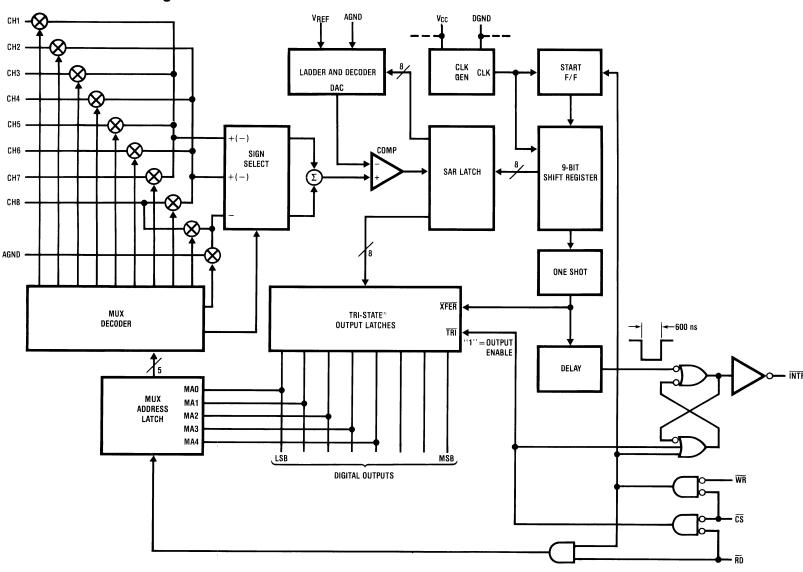
Read strobe must occur at least 600 ns after the assertion of interrupt to ensure reset of $\overline{\text{INTR}}$. MA stands for MUX address.

Figure 11. Using the Previously Selected Channel Configuration and Starting a Conversion





ADC0848 Functional Block Diagram





Functional Description

The ADC0844 and ADC0848 contain a 4-channel and 8-channel analog input multiplexer (MUX) respectively. Each MUX can be configured into one of three modes of operation differential, pseudo-differential, and single ended. These modes are discussed in Applications Information. The specific mode is selected by loading the MUX address latch with the proper address (see Table 1 and Table 2). Inputs to the MUX address latch (MA0-MA4) are common with data bus lines (DB0-DB4) and are enabled when the \overline{RD} line is \overline{high} . A conversion is initiated via the \overline{CS} and \overline{WR} lines. If the data from a previous conversion is not read, the \overline{INTR} line will be low. The falling edge of \overline{WR} will reset the \overline{INTR} line high and ready the A/D for a conversion cycle. The rising edge of \overline{WR} , with \overline{RD} high, strobes the data on the MA0/DB0-MA4/DB4 inputs into the MUX address latch to select a new input configuration and start a conversion. If the \overline{RD} line is held low during the entire low period of \overline{WR} the previous MUX configuration is retained, and the data of the previous conversion is the output on lines DB0-DB7. After the conversion cycle ($\underline{t_C} \leq 40~\mu s$), which is set by the internal clock frequency, the digital data is transferred to the output latch and the \overline{INTR} is asserted low. Taking \overline{CS} and \overline{RD} low resets \overline{INTR} output high and outputs the conversion result on the data lines (DB0-DB7).

APPLICATIONS INFORMATION

MULTIPLEXER CONFIGURATION

The design of these converters utilizes a sampled-data comparator structure which allows a differential analog input to be converted by a successive approximation routine.

The actual voltage converted is always the difference between an assigned "+" input terminal and a "-" input terminal. The polarity of each input terminal of the pair being converted indicates which line the converter expects to be the most positive. If the assigned "+" input is less than the "-" input the converter responds with an all zeros output code.

A unique input multiplexing scheme has been utilized to provide multiple analog channels. The input channels can be software configured into three modes: differential, single ended, or pseudo-differential. Figure 12 shows the three modes using the 4-channel MUX ADC0844. The eight inputs of the ADC0848 can also be configured in any of the three modes. In the differential mode, the ADC0844 channel inputs are grouped in pairs, CH1 with CH2 and CH3 with CH4. The polarity assignment of each channel in the pair is interchangeable. The single-ended mode has CH1–CH4 assigned as the positive input with the negative input being the analog ground (AGND) of the device. Finally, in the pseudo-differential mode CH1–CH3 are positive inputs referenced to CH4 which is now a pseudo-ground. This pseudo-ground input can be set to any potential within the input common-mode range of the converter. The analog signal conditioning required in transducer-based data acquisition systems is significantly simplified with this type of input flexibility. One converter package can now handle ground referenced inputs and true differential inputs as well as signals with some arbitrary reference voltage.

The analog input voltages for each channel can range from 50 mV below ground to 50 mV above V_{CC} (typically 5V) without degrading conversion accuracy.

Product Folder Links: ADC0844 ADC0848



Table 1. ADC0844 MUX ADDRESSING(1)

	MUX A	ddress		CS	WR	RD		MILLY Mode						
MA3	MA2	MA1	MA0	CS	WK	ΚD	CH1	CH2	СНЗ	CH4	AGND	MUX Mode		
Х	L	L	L	L		Н	+	-						
X	L	L	Н	L	NP	Н	-	+				Differential		
X	L	Н	L	L		Н			+	-		Dilleterillal		
X	L	Н	Н	L		Н			-	+				
L	Н	L	L	L		Н	+				-			
L	Н	L	Н	L	NP	Н		+			_	Cinalo Endod		
L	Н	Н	L	L		Н			+		_	Single-Ended		
L	Н	Н	Н	L		Н				+	_			
Н	Н	L	L	L		Н	+			-				
Н	Н	L	Н	L	NP	Н		+		-		Pseudo- Differential		
Н	Н	Н	L	L		Н			+	-				
Х	Х	Х	Х	L	NP	L	Previous Channel Configuration							

(1) X = don't care, NP = negative pulse



Figure 12. Analog Input Multiplexer Options

REFERENCE CONSIDERATIONS

The voltage applied to the reference input of these converters defines the voltage span of the analog input (the difference between $V_{\text{IN(MAX)}}$ and $V_{\text{IN(MIN)}}$) over which the 256 possible output codes apply. The devices can be used in either ratiometric applications or in systems requiring absolute accuracy. The reference pin must be connected to a voltage source capable of driving the minimum reference input resistance of 1.1 k Ω . This pin is the top of a resistor divider string used for the successive approximation conversion.

In a ratiometric system (Figure 13), the analog input voltage is proportional to the voltage used for the A/D reference. This voltage is typically the system power supply, so the V_{REF} pin can be tied to V_{CC} . This technique relaxes the stability requirements of the system reference as the analog input and A/D reference move together maintaining the same output code for a given input condition. For absolute accuracy (Figure 14), where the analog input varies between very specific voltage limits, the reference pin can be biased with a time and temperature stable voltage source. The LM385 and LM336 reference diodes are good low current devices to use with these converters.

The maximum value of the reference is limited to the V_{CC} supply voltage. The minimum value, however, can be quite small (see Typical Performance Characteristics) to allow direct conversions of transducer outputs providing less than a 5V output span. Particular care must be taken with regard to noise pickup, circuit layout and system error voltage sources when operating with a reduced span due to the increased sensitivity of the converter (1 LSB equals $V_{REF}/256$).



THE ANALOG INPUTS

Analog Differential Voltage Inputs and Common-Mode Rejection

The differential input of these converters actually reduces the effects of common-mode input noise, a signal common to both selected "+" and "-" inputs for a conversion (60 Hz is most typical). The time interval between sampling the "+" input and then the "-" inputs is ½ of a clock period. The change in the common-mode voltage during this short time interval can cause conversion errors. For a sinusoidal common-mode signal this error is:

$$V_{\text{ERROR(MAX)}} = V_{\text{peak}} (2\pi f_{\text{CM}}) \times 0.5 \times \left(\frac{t_{\text{C}}}{8}\right)$$

where

- f_{CM} is the frequency of the common-mode signal
- V_{peak} is its peak voltage value
- t_C is the conversion time

For a 60 Hz common-mode signal to generate a ¼ LSB error (≈5 mV) with the converter running at 40 µS, its peak value would have to be 5.43V. This large a common-mode signal is much greater than that generally found in a well designed data acquisition system.

Table 2. ADC0848 MUX Addressing⁽¹⁾

	MU	X Addr	ess				Ι		700-10			Chann					
MA4	MA3	MA2	MA1	MA0	CS	WR	RD	CH1	CH2	СНЗ	CH4	CH5	СН6	CH7	CH8	AGND	MUX Mode
Х	L	L	L	L	L		Н	+	-								
Х	L	L	L	Н	L		Н	-	+								
Х	L	L	Н	L	L		Н			+	-						
Х	L	L	Н	Н	L	NP	Н			_	+						Differential
Х	L	Н	L	L	L		Н					+	-				Dillerential
Х	L	Н	L	Н	L		Н					-	+				
Χ	L	Н	Н	L	L		Н							+	-		
Х	L	Н	Н	Н	┙		Н							-	+		
L	Н	L	L	L	L		Н	+								-	
L	Н	L	L	Н	L		Н		+							-	
L	Н	L	Н	L	L		Н			+						-	
L	Н	L	Н	Н	L	NP	Н				+					-	Single-Ended
L	Н	Н	L	L	L		Н					+				-	Single-Ended
L	Н	Н	L	Н	L		Н						+			-	
L	Н	Н	Н	L	L		Н							+		-	
L	Н	Н	Н	Н	L		Н								+	-	
Н	Н	L	L	L	L		Н	+							-		
Н	Н	L	L	Н	L		Н		+						-		
Н	Н	L	Н	L	L		Н			+					-		5 .
Н	Н	L	Н	Н	L	NP	Н				+				-		Pseudo- Differential
Н	Н	Н	L	L	L		Н					+			-		
Н	Н	Н	L	Н	L		Н						+		-		
Н	Н	Н	Н	L	L		Н							+	-		
Χ	Χ	Χ	X	Χ	L		L			Prev	ious Cl	hannel	Configu	ıration			

(1) X = don't care, NP = negative pulse



Input Current

Due to the sampling nature of the analog inputs, short duration spikes of current enter the "+" input and exit the "-" input at the clock edges during the actual conversion. These currents decay rapidly and do not cause errors as the internal comparator is strobed at the end of a clock period. Bypass capacitors at the inputs will average these currents and cause an effective DC current to flow through the output resistance of the analog signal source. Bypass capacitors should not be used if the source resistance is greater than 1 k Ω .

Input Source Resistance

The limitation of the input source resistance due to the DC leakage currents of the input multiplexer is important. A worst-case leakage current of \pm 1 μ A over temperature will create a 1 mV input error with a 1 $k\Omega$ source resistance. An op amp RC active low pass filter can provide both impedance buffering and noise filtering should a high impedance signal source be required.

OPTIONAL ADJUSTMENTS

Zero Error

The zero of the A/D does not require adjustment. If the minimum analog input voltage value, $V_{IN(MIN)}$, is not ground, a zero offset can be done. The converter can be made to output 0000 0000 digital code for this minimum input voltage by biasing any V_{IN} (-) input at this $V_{IN(MIN)}$ value. This is useful for either differential or pseudo-differential modes of input channel configuration.

The zero error of the A/D converter relates to the location of the first riser of the transfer function and can be measured by grounding the V⁻ input and applying a small magnitude positive voltage to the V⁺ input. Zero error is the difference between actual DC input voltage which is necessary to just cause an output digital code transition from 0000 0000 to 0000 0001 and the ideal $\frac{1}{2}$ LSB value ($\frac{1}{2}$ LSB=9.8 mV for V_{REF}=5.000 V_{DC}).

Full-Scale

The full-scale adjustment can be made by applying a differential input voltage which is 1 $\frac{1}{2}$ LSB down from the desired analog full-scale voltage range and then adjusting the magnitude of the V_{REF} input for a digital output code changing from 1111 1110 to 1111 1111.

Adjusting for an Arbitrary Analog Input Voltage Range

If the analog zero voltage of the A/D is shifted away from ground (for example, to accommodate an analog input signal which does not go to ground), this new zero reference should be properly adjusted first. A V_{IN} (+) voltage which equals this desired zero reference plus ½ LSB (where the LSB is calculated for the desired analog span, 1 LSB = analog span/256) is applied to selected "+" input and the zero reference voltage at the corresponding "-" input should then be adjusted to just obtain the 00_{HEX} to 01_{HEX} code transition.

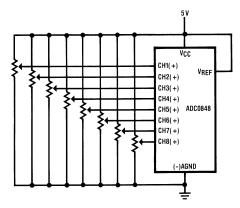


Figure 13. Referencing Examples - Ratiometric



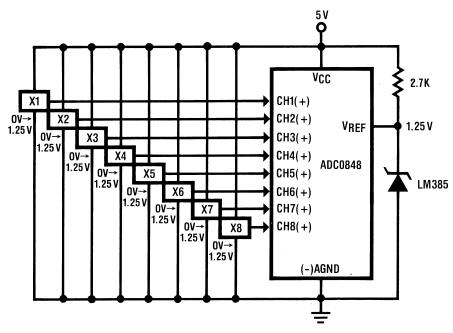


Figure 14. Referencing Examples - Absolute with a Reduced Span

The full-scale adjustment should be made [with the proper V_{IN} (-) voltage applied] by forcing a voltage to the V_{IN} (+) input which is given by:

$$V_{IN}(+)$$
 fs adj = $V_{MAX} - 1.5 \left[\frac{(V_{MAX} - V_{MIN})}{256} \right]$

where

- V_{MAX} = the high end of the analog input range
- V_{MIN} = the low end (the offset zero) of the analog range. (Both are ground referenced.)

The V_{REF} (or V_{CC}) voltage is then adjusted to provide a code change from FE_{HEX} to FF_{HEX} . This completes the adjustment procedure.

For an example see the Zero-Shift and Span Adjust circuit below.

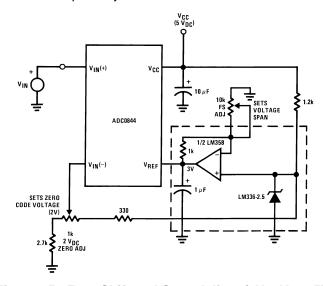


Figure 15. Zero-Shift and Span Adjust ($2V \le V_{IN} \le 5V$)



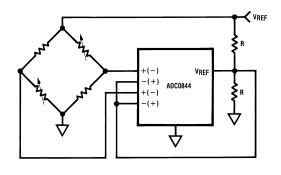


Figure 16. Differential Voltage Input 9-Bit A/D

Figure 17. Span Adjust (0V \leq V_{IN} \leq 3V)

Diodes are 1N914

```
DO = all 1s if V_{IN}(+)>V_{IN}(-)
DO = all 0s if V_{IN}(+)< V_{IN}(-)
```

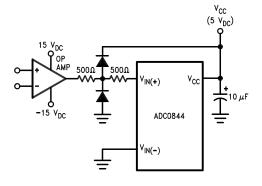


Figure 18. Protecting the Input

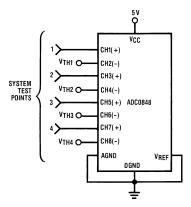


Figure 19. High Accuracy Comparators



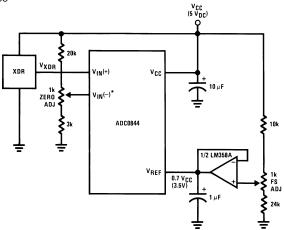
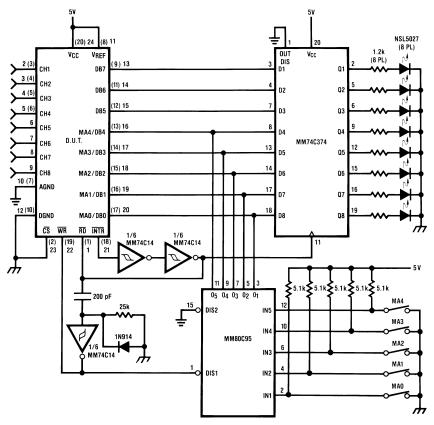


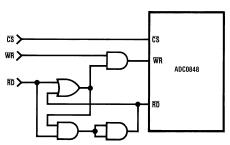
Figure 20. Operating with Automotive Ratiometric Transducers





Note: DUT pin numbers in parentheses are for ADC0844, others are for ADC0848.

Figure 21. A Stand Alone Circuit



CS •WR will update the channel configuration and start a conversion.

CS •RD will read the conversion data and start a new conversion without updating the channel configuration. Waiting for the end of this conversion is not necessary. A CS •WR can immediately follow the CS•RD.

Figure 22. Start a Conversion without Updating the Channel Configuration



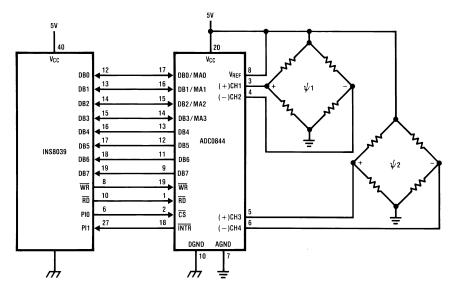


Figure 23. ADC0844—INS8039 Interface

Sample Program for ADC0844 - INS8039 Interface Converting Two Ratiometric Differential Signals

				ORG	0H	
0000	04	10		JMP	BEGIN	;START PROGRAM AT ADDR 10
				ORG	10H	;MAIN PROGRAM
0010	В9	FF	BEGIN:	MOV	R1,#0FFH	;LOAD R1 WITH AN UNUSED ADDR
						;LOCATION
0012	В8	20		MOV	R0,#20H	;A/D DATA ADDRESS
0014	89	FF		ORL	P1,#0FFH	;SET PORT 1 OUTPUTS HIGH
0016	23	00		MOV	A,00H	;LOAD THE ACC WITH A/D MUX DATA
						;CH1 AND CH2 DIFFERENTIAL
0018	14	50		CALL	CONV	; CALL THE CONVERSION SUBROUTINE
001A	23	02		MOV	A,#02H	;LOAD THE ACC WITH A/D MUX DATA
						;CH3 AND CH4 DIFFERENTIAL
001C	18			INC	R0	; INCREMENT THE A/D DATA ADDRESS
001D	14	50		CALL	CONV	; CALL THE CONVERSION SUBROUTINE
				; CONTI	NUE MAIN PROGRAM	
					RSION SUBROUTINE	
					:ACC-A/D MUX DATA	
				;EXIT:	ACC-CONVERTED DATA	
				ORG	50н	
0050	99	rr.	CONV:	ANL	P1#0FEH	;CHIP SELECT THE A/D
0050	91	LE	CONV	MOVX	@R1,A	;LOAD A/D MUX & START CONVERSION
0052	09		LOOP:	IN	A,P1	; INPUT INTR STATE
0053	32	E 2	LOOP.	JB1	LOOP	; IF INTR = 1 GOTO LOOP
0054	81	33		MOVX	A,@R1	; IF INTR = 0 INPUT A/D DATA
0057	89	0.1		ORL	P1,&01H	CLEAR THE A/D CHIP SELECT
0057	A0	OΤ		MOV	@RO,A	STORE THE A/D CAIP SELECT
005A	83			RET	ero, A	RETURN TO MAIN PROGRAM
UUJA	03			1/17 1		/KEIOKN IO MAIN PROGRAM



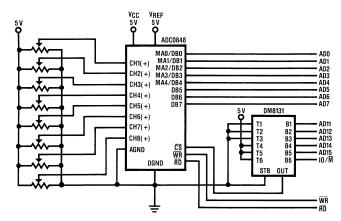


Figure 24. I/O Interface to NSC800

Sample Program for ADC0848 - NSC800 Interface

0008 000F 001F 3C00		NCONV DEL CS ADDTA	EQU EQU EQU EQU	16 15 1FH 003CH	;DELAY 50 µSEC CONVERSION ;THE BOARD ADDRESS ;START OF RAM FOR A/D ;DATA
0000' 0004' 0008' 000A' 000C'	08 09 0A 0B 0C 0D 0E 0F 0E 1F 06 16 21 0000'	MUXDTA: START:	DB DB LD LD LD	08H,09H,0AH,0BH 0CH,0DH,0EH,0FH C,CS B,NCONV HL,MUXDTA	;MUX DATA
000F' 0012'	11 003C ED A3	STCONV:	LD OUTI	DE, ADDTA	;LOAD A/D'S MUX DATA
0014'	EB	D1001.V	EX	DE,HL	;AND START A CONVERSION ;HL=RAM ADDRESS FOR THE ;A/D DATA
0015'	3E 0F		LD	A,DEL	
0017'	3D	WAIT:	DEC	A	;WAIT 50 µSEC FOR THE
0018'	C2 0013'		JP	NZ,WAIT	CONVERSION TO FINISH
001B'	ED A2		INI		;STORE THE A/D'S DATA ;CONVERTED ALL INPUTS?
001D'	EB		EX	DE,HL	
001E'	C2 000E'		JP	NZ,STCONV	; IF NOT GOTO STCONV
			END		

Note: This routine sequentially programs the MUX data latch in the signal-ended mode. For CH1-CH8 a conversion is started, then a 50 μ s wait for the A/D to complete a conversion and the data is stored at address ADDTA for CH1, ADDTA + 1 for CH2, etc.



REVISION HISTORY

Cł	nanges from Revision C (March 2013) to Revision D	Pag	jε
•	Changed layout of National Data Sheet to TI format	. 1	7





22-Dec-2017

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	•	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
ADC0844CCN/NOPB	LIFEBUY	PDIP	NFH	20	18	Green (RoHS & no Sb/Br)	CU SN	Level-1-NA-UNLIM	0 to 70	ADC0844CCN	
ADC0848BCV	LIFEBUY	PLCC	FN	28	35	TBD	Call TI	Call TI	-40 to 85	ADC0848 BCV	
ADC0848BCV/NOPB	ACTIVE	PLCC	FN	28	35	Green (RoHS & no Sb/Br)	CU SN	Level-2A-245C-4 WEEK	-40 to 85	ADC0848 BCV	Samples
ADC0848BCVX/NOPB	ACTIVE	PLCC	FN	28	750	Green (RoHS & no Sb/Br)	CU SN	Level-2A-245C-4 WEEK	-40 to 85	ADC0848 BCV	Samples
ADC0848CCN	LIFEBUY	PDIP	NAM	24	15	TBD	Call TI	Call TI	-40 to 85	ADC0848CCN	
ADC0848CCV	LIFEBUY	PLCC	FN	28	35	TBD	Call TI	Call TI	-40 to 85	ADC0848 CCV	
ADC0848CCV/NOPB	ACTIVE	PLCC	FN	28	35	Green (RoHS & no Sb/Br)	CU SN	Level-2A-245C-4 WEEK	-40 to 85	ADC0848 CCV	Samples
ADC0848CCVX	LIFEBUY	PLCC	FN	28	750	TBD	Call TI	Call TI	-40 to 85	ADC0848 CCV	
ADC0848CCVX/NOPB	ACTIVE	PLCC	FN	28	750	Green (RoHS & no Sb/Br)	CU SN	Level-2A-245C-4 WEEK	-40 to 85	ADC0848 CCV	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



PACKAGE OPTION ADDENDUM

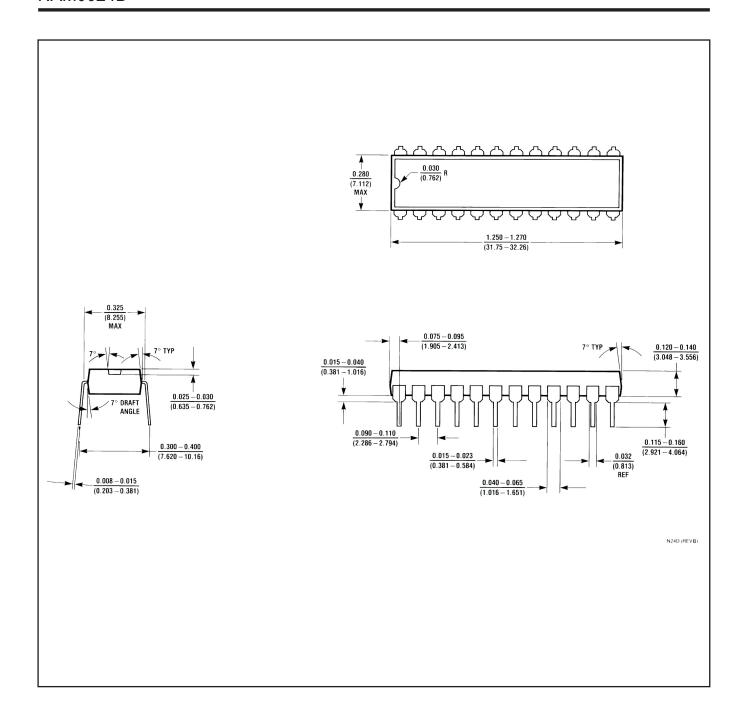
22-Dec-2017

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

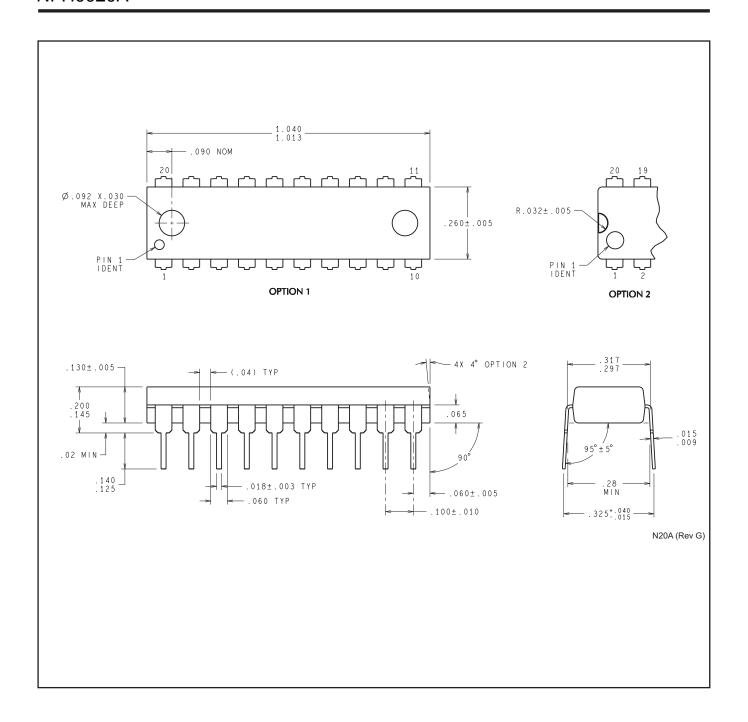
(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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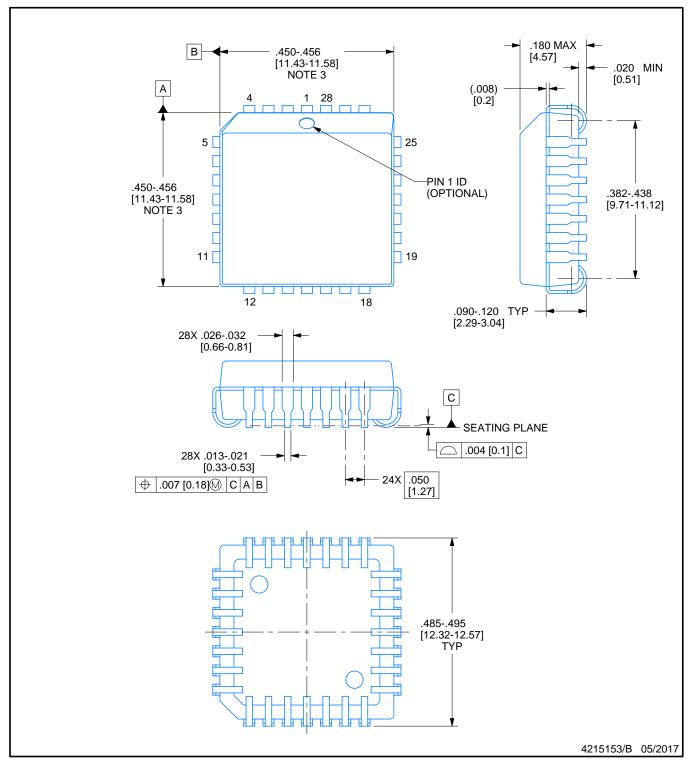


Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040005-3/C



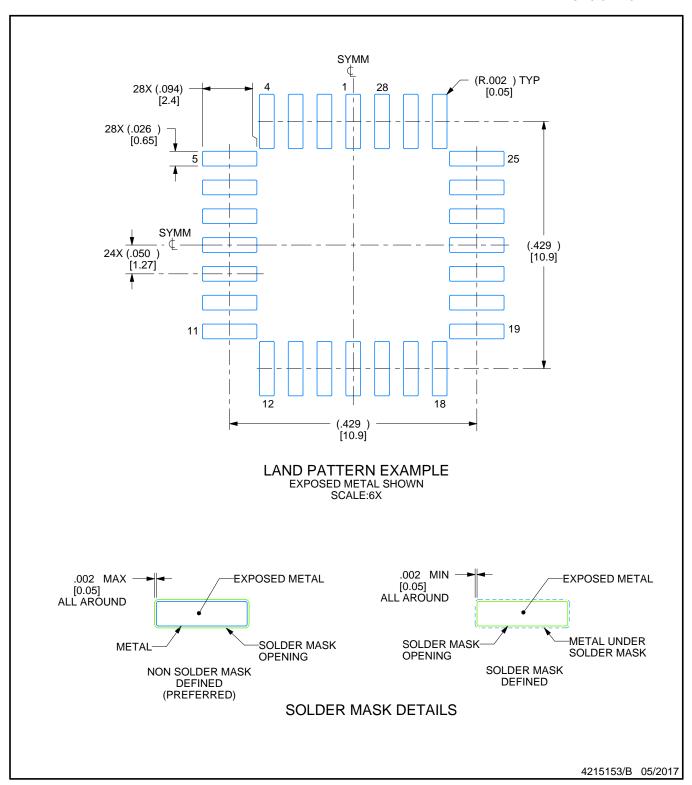




NOTES:

- 1. All linear dimensions are in inches. Any dimensions in brackets are in millimeters. Any dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. Dimension does not include mold protrusion. Maximum allowable mold protrusion .01 in [0.25 mm] per side. 4. Reference JEDEC registration MS-018.



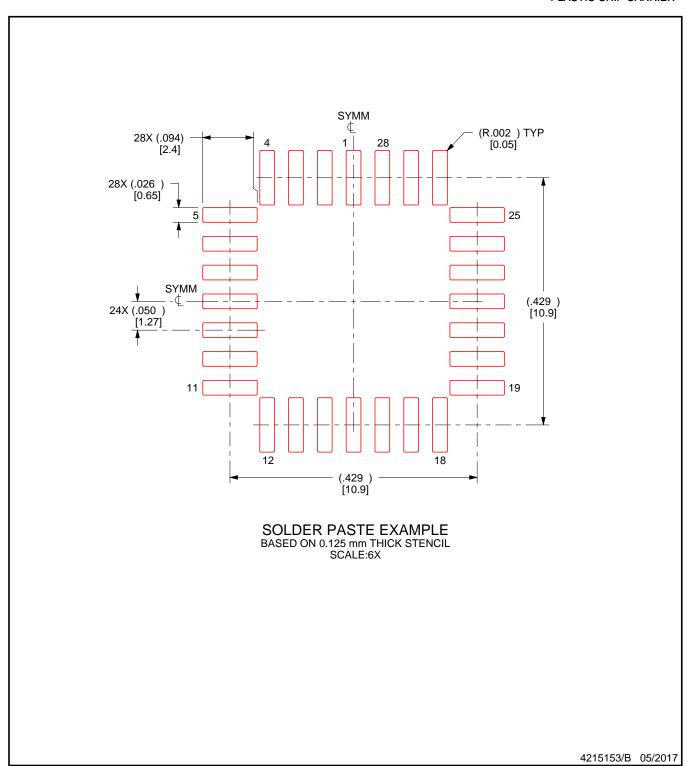


NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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